

STN	Zabezpečovanie výrobkov kozmického programu. Návrh, výber, obstarávanie a používanie monolitických mikrovlnných integrovaných obvodov (MMIC).	STN EN 16602-60-12
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Space product assurance - Design, selection, procurement and use of die form monolithic microwave integrated circuits (MMICs)

Táto norma obsahuje anglickú verziu európskej normy.

This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 01/15

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English version

**Space product assurance - Design, selection, procurement and
use of die form monolithic microwave integrated circuits
(MMICs)**

Assurance produit des projets spatiaux - Conception,
élection, approvisionnement et utilisation de circuits
intégrés monolithique hyperfréquence de forme die

Raumfahrtproduksicherung - Design, Auswahl,
Beschaffung und Nutzung von MMIC

This European Standard was approved by CEN on 13 March 2014.

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Foreword

This document (EN 16602-60-12:2014) has been prepared by Technical Committee CEN/CLC/TC 5 "Space", the secretariat of which is held by DIN.

This standard (EN 16602-60-12:2014) originates from ECSS-Q-ST-60-12C.

This European Standard shall be given the status of a national standard, either by publication of an identical text or by endorsement, at the latest by March 2015, and conflicting national standards shall be withdrawn at the latest by March 2015.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CEN [and/or CENELEC] shall not be held responsible for identifying any or all such patent rights.

This document has been prepared under a mandate given to CEN by the European Commission and the European Free Trade Association.

This document has been developed to cover specifically space systems and has therefore precedence over any EN covering the same scope but with a wider domain of applicability (e.g. : aerospace).

According to the CEN-CENELEC Internal Regulations, the national standards organizations of the following countries are bound to implement this European Standard: Austria, Belgium, Bulgaria, Croatia, Cyprus, Czech Republic, Denmark, Estonia, Finland, Former Yugoslav Republic of Macedonia, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.

Introduction

This Standard covers the design, selection, procurement and use of III-V monolithic microwave integrated circuits (MMICs) for space equipment.

It defines the design activity for the technical (methodology, phases to be followed) and quality (quality assurance, design review) aspects, and, the selection and procurement rules for these components taking into account whether or not the processes have been validated.

1**Scope**

This Standard applies to all types of MMIC (monolithic microwave integrated circuit) based on III-V compound materials for RF applications (i.e. frequency range ≥ 1 GHz). The requirements for the procurement of components in die form are defined.

It is not within the scope of this Standard to address packaged MMICs and discrete microwave components, these are dealt with in the relevant ESCC specification (ESCC 9010 and ESCC 5010).

This standard may be tailored for the specific characteristic and constraints of a space project in conformance with ECSS-S-ST-00.

2**Normative references**

The following normative documents contain provisions which, through reference in this text, constitute provisions of this ECSS Standard. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this ECSS Standard are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references the latest edition of the publication referred to applies.

EN reference	Reference in text	Title
EN 16601-00-01	ECSS-S-ST-00-01	ECSS system – Glossary of terms
EN 16602-30-11	ECSS-Q-ST-30-11	Space product assurance – Derating -- EEE components
EN 16602-60	ECSS-Q-ST-60	Space product assurance - Electrical, electronic and electromechanical (EEE) components
EN 16602-60-05	ECSS-Q-ST-60-05	Space product assurance – Generic requirements for hybrids
	MIL-STD-883	Tests methods and procedures for microelectronics
	ESCC 20600	Preservation, packaging and despatch of ESCC electronic components
	ESCC 24600	Minimum quality management system requirements
	ESCC 2049010	Internal visual inspection of monolithic microwave devices
	ESCC 2439010	Requirements for capability approval of MMICs
	ESCC 9010	Generic specification for MMICs

koniec náhľadu – text d'alej pokračuje v platenej verzii STN